


<b>Search Notes</b>  	<b>Application/Control No.</b>  10073772	<b>Applicant(s)/Patent Under Reexamination</b>  HAITSMA ET AL.
	<b>Examiner</b>  Yogesh Paliwal	<b>Art Unit</b>  2135

SEARCHED			
Class	Subclass	Date	Examiner
Updated	Search	2/2/07	PWK
713	168, 162, 186, 168-181	8/6/07	PWK
Updated	Search	8/6/07	PWK
Updated	Search	11/25/07	PWK
Updated	Search	1/4/08	PWK

SEARCH NOTES		
Search Notes	Date	Examiner
Updated Search	8/6/07	PWK
380/54.CCLS. and ((hash\$5 (digital near signature)) with (frame near block))	8/6/07	PWK
Updated Search	11/25/07	PWK
IEEE	1/4/08	PWK
Inventor name search in East	4/09/2008	YP
(713/162,168-181,182,185,186) + Keyword search- see search history printout	4/09/2008	YP
(380/54,55,210,231,232) + Keyword search - see search history printout	4/09/2008	YP
(382/100,190,195,199)+ Keyword search - see search history printout	4/09/2008	YP
(714/704) + Keyword search- see search history printout	4/09/2008	YP
(348/461,467) + Keyword search - see search history printout	4/09/2008	YP
Other keyword searches in East- see search history printout	4/09/2008	YP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
713	168162, 186, 168-181	2/2/07	PWK
380	54 (hash and identif\$7 and reliable and unreliable).CLM.	2/2/07	PWK
713	168162, 186, 168-181 and ((hash\$5 (digital near signature)) with (frame block)).CLM.	8/6/07	PWK
380	54 and ((hash\$5 (digital near signature)) with (frame block)).CLM.	8/6/07	PWK
	(hash and identif\$7 and reliable and unreliable).CLM.	4/09/2008	YP